



### **Application**

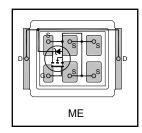
- Brushed motor drive applications
- BLDC motor drive applications
- Battery powered circuits
- Half-bridge and full-bridge topologies
- Synchronous rectifier applications
- Resonant mode power supplies
- OR-ing and redundant power switches
- DC/DC and AC/DC converters
- DC/AC inverters

### **Benefits**

- Improved gate, avalanche and dynamic dv/dt ruggedness
- Fully characterized capacitance and avalanche SOA
- Enhanced body diode dv/dt and di/dt capability
- Lead-free, RoHS compliant

### DirectFET® N-Channel Power MOSFET

V <sub>DSS</sub>	60V
R <sub>DS(on)</sub> typ.	<b>2.9m</b> Ω
max	3.6mΩ
I <sub>D</sub>	114A





Deec new number	Dookses Time	Standard Pack	Orderable Part Number	
Base part number	Package Type	Form	Quantity	
IRF7580MPbF	DirectFET® ME	Tape and Reel	4800	IRF7580MTRPbF

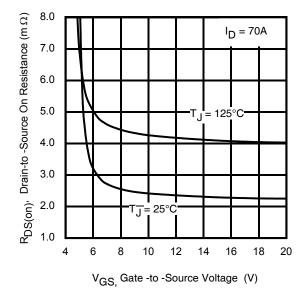


Fig 1. Typical On-Resistance vs. Gate Voltage

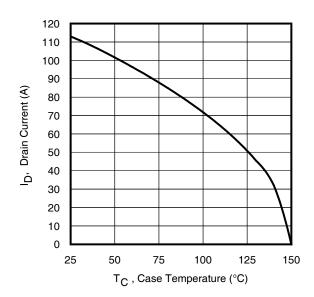


Fig 2. Maximum Drain Current vs. Case Temperature



**Absolute Maximum Ratings** 

Symbol	Parameter	Max.	Units
$I_D$ @ $T_C$ = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	114	
$I_D @ T_C = 100^{\circ}C$	Continuous Drain Current, V <sub>GS</sub> @ 10V	72	Α
I <sub>DM</sub>	Pulsed Drain Current ①	452	
$P_D @ T_C = 25^{\circ}C$	Maximum Power Dissipation	96	W
	Linear Derating Factor	0.78	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	V
$T_J$	Operating Junction and	-55 to + 150	°C
T <sub>STG</sub>	Storage Temperature Range		C

### **Avalanche Characteristics**

E <sub>AS</sub> (Thermally limited)	Single Pulse Avalanche Energy ②	81	mJ
E <sub>AS</sub> (Thermally limited)	Single Pulse Avalanche Energy	149	
$I_{AR}$	Avalanche Current ①	Coo Fig 15 16 220 22h	Α
E <sub>AR</sub>	Repetitive Avalanche Energy ①	See Fig.15,16 , 23a, 23b	mJ

### **Thermal Resistance**

Symbol	Parameter	Тур.	Max.	Units
$R_{ hetaJA}$	Junction-to-Ambient ●⑦		44	
$R_{ hetaJA}$	Junction-to-Ambient <b>⑤</b>	12.5		
$R_{ heta JA}$	Junction-to-Ambient <b>②</b>	20		°C/W
$R_{ heta JC}$	Junction-to-Case <b>4</b> ®		1.3	
$R_{\theta J\text{-PCB}}$	Junction-to-PCB Mounted <b>②</b>	0.75		

Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	60			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		44		mV/°C	Reference to 25°C, I <sub>D</sub> = 1.0mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		2.9	3.6	mΩ	$V_{GS} = 10V, I_D = 70A $ ④
			3.5		mΩ	$V_{GS} = 6.0V, I_D = 35A \oplus$
$V_{GS(th)}$	Gate Threshold Voltage	2.1		3.7	V	$V_{DS} = V_{GS}, I_{D} = 150 \mu A$
I <sub>DSS</sub>	Drain-to-Source Leakage Current			1.0	μΑ	$V_{DS} = 60V, V_{GS} = 0V$
				150		$V_{DS} = 60V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
$I_{GSS}$	Gate-to-Source Forward Leakage			100	nA	V <sub>GS</sub> = 20V
	Gate-to-Source Reverse Leakage			-100		V <sub>GS</sub> = -20V
$R_G$	Internal Gate Resistance		0.8		Ω	

### Notes:

- Mounted on minimum footprint full size board with metalized back and with small clip heatsink.
- Used double sided cooling , mounting pad with large heatsink.
- $\ensuremath{\mathbf{0}}$  TC measured with thermocouple mounted to top (Drain) of part.



 Surface mounted on 1 in. square Cu board (still air).



Mounted to a PCB with small clip heatsink (still air)



Mounted on minimum footprint full size board with metalized back and with small clip heatsink (still air)



Dynamic @ T<sub>J</sub> = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
gfs	Forward Transconductance	190			S	$V_{DS} = 10V, I_{D} = 70A$
$Q_g$	Total Gate Charge		120	180		I <sub>D</sub> = 70A
$Q_{gs}$	Gate-to-Source Charge		32	—	nC	V <sub>DS</sub> =30V
$Q_{gd}$	Gate-to-Drain ("Miller") Charge		36	_	110	V <sub>DS</sub> =30V V <sub>GS</sub> = 10V ④
Q <sub>sync</sub>	Total Gate Charge Sync. (Q <sub>g</sub> - Q <sub>gd</sub> )		84			
$t_{d(on)}$	Turn-On Delay Time		20			$V_{DD} = 30V$
t <sub>r</sub>	Rise Time		38		no	$I_{D} = 30A$
$t_{d(off)}$	Turn-Off Delay Time		53		ns	$R_G = 2.7\Omega$
t <sub>f</sub>	Fall Time		21			V <sub>GS</sub> = 10V ④
C <sub>iss</sub>	Input Capacitance		6510			$V_{GS} = 0V$
C <sub>oss</sub>	Output Capacitance		610			V <sub>DS</sub> = 25V
	Reverse Transfer Capacitance		360		рF	f = 1.0MHz
C <sub>oss</sub> eff. (ER)	Effective Output Capacitance (Energy Related)		620			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 48V $
C <sub>oss</sub> eff. (TR)	Effective Output Capacitance (Time Related)		770			V <sub>GS</sub> = 0V, V <sub>DS</sub> = 0V to 48V ⑤

### **Diode Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current			105	Α	MOSFET symbol
	(Body Diode)					showing the
I <sub>SM</sub>	Pulsed Source Current			460		integral reverse
	(Body Diode) ①					p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.2	٧	$T_J = 25^{\circ}C, I_S = 70A, V_{GS} = 0V$
dv/dt	Peak Diode Recovery ③		4.1		V/ns	$T_J = 150^{\circ}C, I_S = 70A, V_{DS} = 60V$
t <sub>rr</sub>	Reverse Recovery Time		41		ns	$T_J = 25^{\circ} \text{ C}  V_R = 51 \text{ V},$
			44			$T_J = 125^{\circ}C$ $I_F = 70A$
Q <sub>rr</sub>	Reverse Recovery Charge		55		nC	T <sub>J</sub> = 25°C di/dt = 100A/µs ④
			71			T <sub>J</sub> = 125°C
I <sub>RRM</sub>	Reverse Recovery Current		2.5		Α	T <sub>J</sub> = 25°C

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Limited by  $T_J$  max, starting  $T_J$  = 25°C, L = 34 $\mu$ H  $R_G$  = 50 $\Omega$ ,  $I_{AS}$  = 70A,  $V_{GS}$  =10V.
- ③  $I_{SD} \le 70A$ , di/dt ≤ 980A/ $\mu$ s,  $V_{DD} \le V(_{BR)DSS}$ ,  $T_{J} \le 150$ °C.
- ④ Pulse width  $\leq$  400µs; duty cycle  $\leq$  2%.
- $\ ^{\circ}$  C  $_{oss}$  eff. (TR) is a fixed capacitance that gives the same charging time as C  $_{oss}$  while V  $_{DS}$  is rising from 0 to 80% V  $_{DSS}.$
- ©  $C_{oss}$  eff. (ER) is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.
- Limited by T<sub>J</sub> max, starting T<sub>J</sub> = 25°C, L= 1mH, R<sub>G</sub> = 50Ω, I<sub>AS</sub> = 17A, V<sub>GS</sub> =10V.



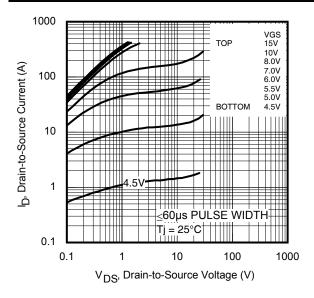


Fig 3. Typical Output Characteristics

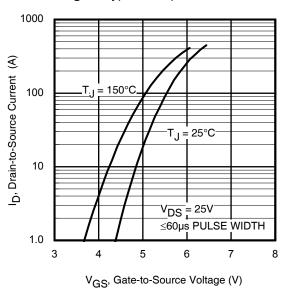


Fig 5. Typical Transfer Characteristics

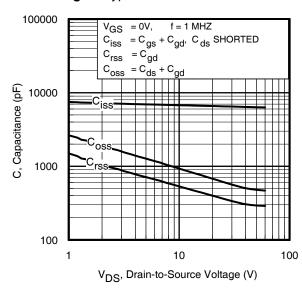


Fig 7. Typical Capacitance vs. Drain-to-Source Voltage

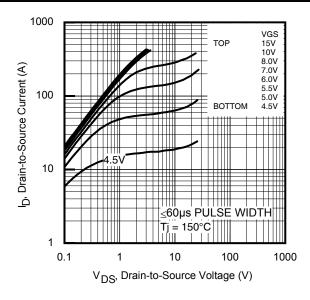


Fig 4. Typical Output Characteristics

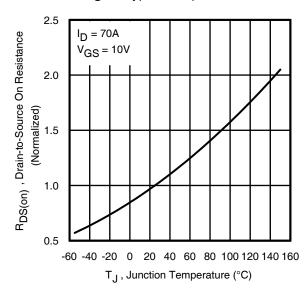


Fig 6. Normalized On-Resistance vs. Temperature

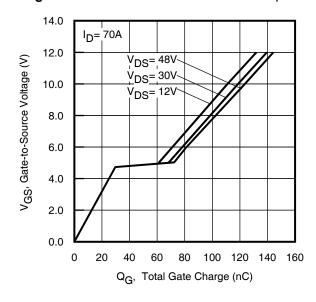


Fig 8. Typical Gate Charge vs. Gate-to-Source Voltage



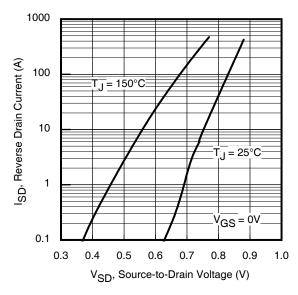


Fig 9. Typical Source-Drain Diode Forward Voltage

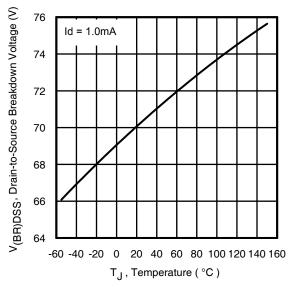


Fig 11. Drain-to-Source Breakdown Voltage

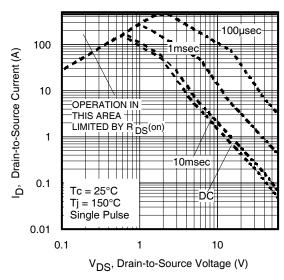


Fig 10. Maximum Safe Operating Area

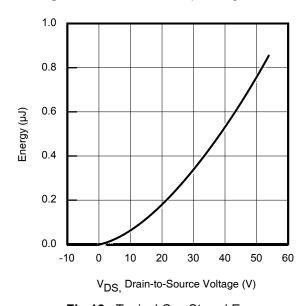


Fig 12. Typical Coss Stored Energy

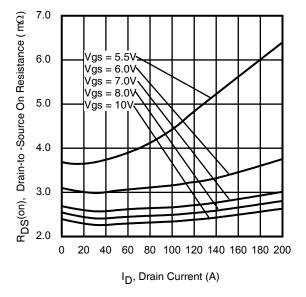


Fig 13. Typical On-Resistance vs. Drain Current



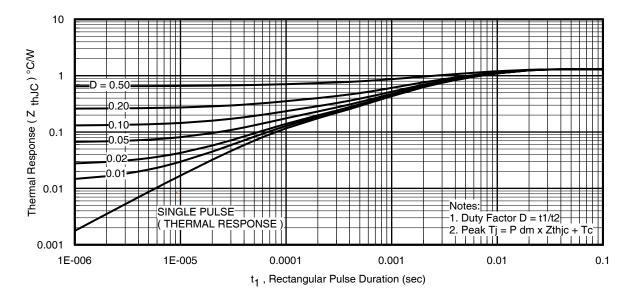


Fig 14. Maximum Effective Transient Thermal Impedance, Junction-to-Case

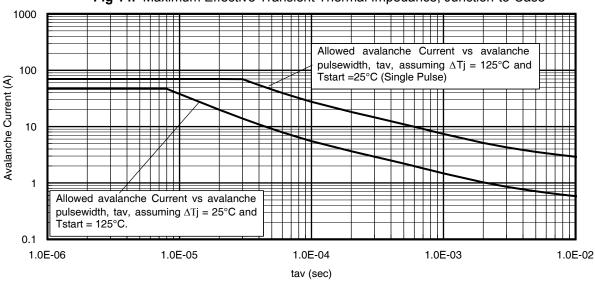


Fig 15. Avalanche Current vs. Pulse Width

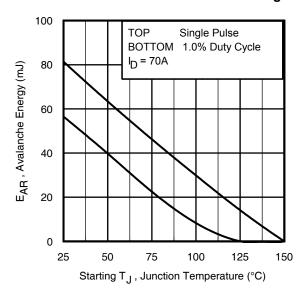


Fig 16. Maximum Avalanche Energy vs. Temperature

#### Notes on Repetitive Avalanche Curves, Figures 15, 16: (For further info, see AN-1005 at www.irf.com)

1. Avalanche failures assumption:

Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{\text{jmax}}$ . This is validated for every

- 2. Safe operation in Avalanche is allowed as long  $asT_{j\text{max}}$  is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 23a, 23b.
- 4. P<sub>D (ave)</sub> = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I<sub>av</sub> = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{imax}$ (assumed as 25°C in Figure 14, 15).

t<sub>av</sub> = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

 $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see Figures 13) PD (ave) = 1/2 (  $1.3 \cdot BV \cdot I_{av}$ ) =  $\Delta T/Z_{thJC}$ 

 $I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$ 

 $E_{AS (AR)} = P_{D (ave)} t_{av}$ 



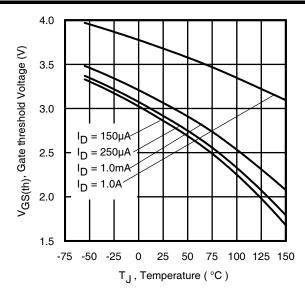


Fig 17. Threshold Voltage vs. Temperature

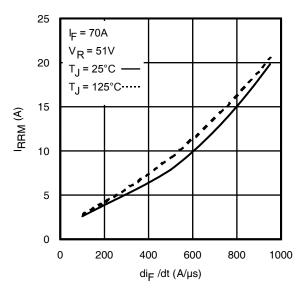


Fig 19. Typical Recovery Current vs. dif/dt

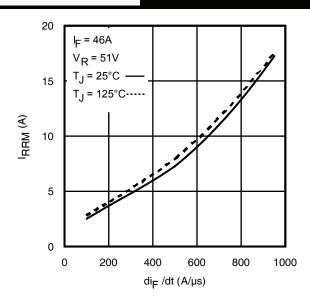


Fig 18. Typical Recovery Current vs. dif/dt

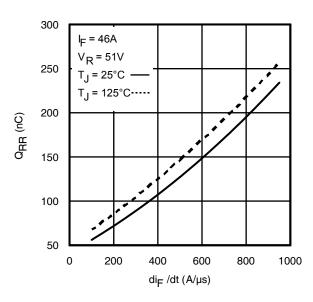


Fig 20. Typical Stored Charge vs. dif/dt

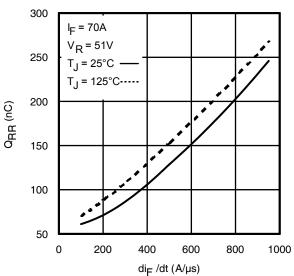


Fig 21. Typical Stored Charge vs. dif/dt



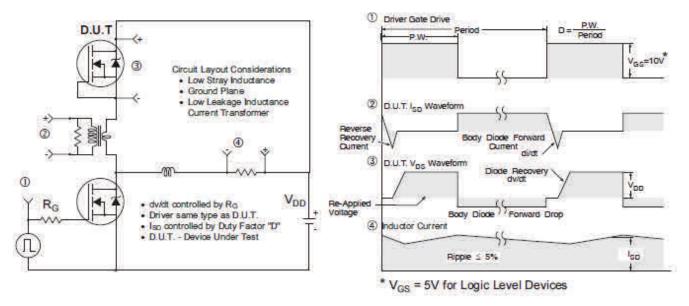


Fig 22. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

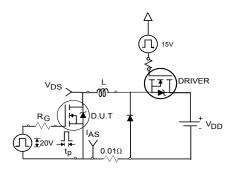


Fig 23a. Unclamped Inductive Test Circuit

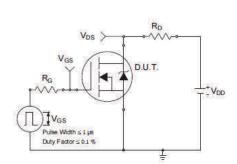


Fig 24a. Switching Time Test Circuit

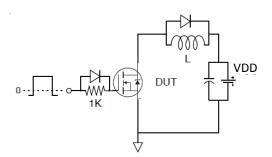


Fig 25a. Gate Charge Test Circuit

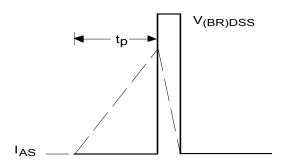


Fig 23b. Unclamped Inductive Waveforms

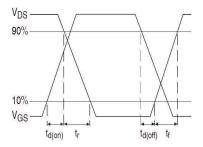


Fig 24b. Switching Time Waveforms

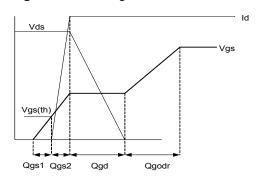
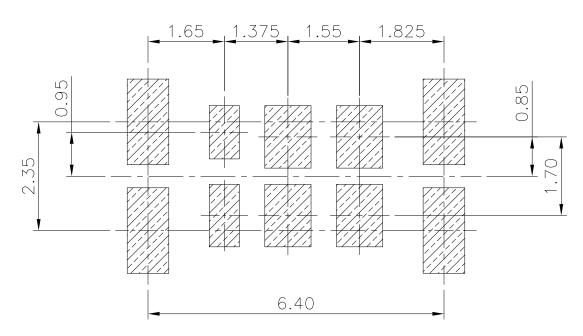


Fig 25b. Gate Charge Waveform



# DirectFET® Board Footprint, ME Outline (Medium Size Can, E-Designation)

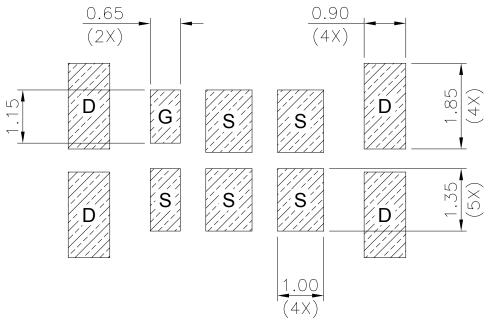
Please see DirectFET<sup>®</sup> application note AN-1035 for all details regarding the assembly of DirectFET<sup>®</sup>. This includes all recommendations for stencil and substrate designs.



G = GATE

D = DRAIN

S = SOURCE

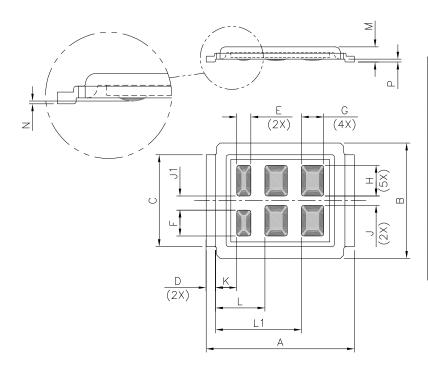


Note: For the most current drawing please refer to IR website at <a href="http://www.irf.com/package/">http://www.irf.com/package/</a>



## DirectFET<sup>®</sup> Outline Dimension, ME Outline (Medium Size Can, E-Designation)

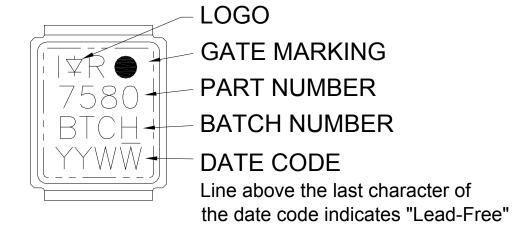
Please see DirectFET® application note AN-1035 for all details regarding the assembly of DirectFET®. This includes all recommendations for stencil and substrate designs.



DIMENSIONS					
	METRIC			RIAL	
CODE	MIN	MAX	MIN	MAX	
Α	6.25	6.35	0.246	0.250	
В	4.80	5.05	0.189	0.199	
С	3.85	3.95	0.152	0.156	
D	0.35	0.45	0.014	0.018	
Е	0.58	0.62	0.023	0.024	
F	1.08	1.12	0.043	0.044	
G	0.93	0.97	0.037	0.038	
Н	1.28	1.32	0.050	0.052	
J	0.38	0.42	0.015	0.017	
J1	0.58	0.62	0.023	0.024	
K	0.88	0.92	0.035	0.036	
L	2.08	2.12	0.082	0.083	
L1	3.63	3.67	0.143	0.144	
М	0.59	0.70	0.023	0.028	
N	0.02	0.08	0.0008	0.003	
Р	0.08	0.17	0.003	0.007	

Dimensions are shown in millimeters (inches)

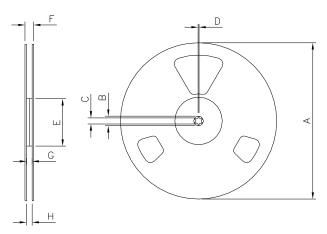
### DirectFET® Part Marking



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



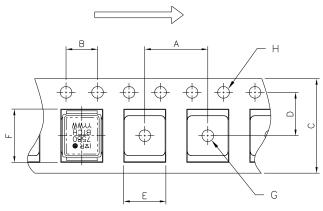
### **DirectFET®** Tape & Reel Dimension (Showing component orientation).



NOTE: Controlling dimensions in mm Std reel quantity is 4800 parts. (ordered as IRF7580MTRPBF). For 1000 parts on 7" reel, order IRF7580MTR1PBF

	REEL DIMENSIONS								
S <sup>-</sup>	TANDARI	OPTION	I (QTY 48	00)	TR	1 OPTION	(QTY 10	00)	
	ME	TRIC	IMP	ERIAL	ME	TRIC	IMP	ERIAL	
CODE	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
Α	330.0	N.C	12.992	N.C	177.77	N.C	6.9	N.C	
В	20.2	N.C	0.795	N.C	19.06	N.C	0.75	N.C	
С	12.8	13.2	0.504	0.520	13.5	12.8	0.53	0.50	
D	1.5	N.C	0.059	N.C	1.5	N.C	0.059	N.C	
Е	100.0	N.C	3.937	N.C	58.72	N.C	2.31	N.C	
F	N.C	18.4	N.C	0.724	N.C	13.50	N.C	0.53	
G	12.4	14.4	0.488	0.567	11.9	12.01	0.47	N.C	
Н	11.9	15.4	0.469	0.606	11.9	12.01	0.47	N.C	

### LOADED TAPE FEED DIRECTION



NOTE: CONTROLLING DIMENSIONS IN MM

DIMENSIONS						
	MET	RIC	IMPE	RIAL		
CODE	MIN	MAX	MIN	MAX		
Α	7.90	8.10	0.311	0.319		
В	3.90	4.10	0.154	0.161		
С	11.90	12.30	0.469	0.484		
D	5.45	5.55	0.215	0.219		
E	5.10	5.30	0.201	0.209		
F	6.50	6.70	0.256	0.264		
G	1.50	N.C	0.059	N.C		
Н	1.50	1.60	0.059	0.063		

Note: For the most current drawing please refer to IR website at <a href="http://www.irf.com/package/">http://www.irf.com/package/</a>



### Qualification Information<sup>†</sup>

Qualification Level	Industrial (per JEDEC JESD47F <sup>††</sup> guidelines)				
Moisture Sensitivity Level	DFET 1.5	MSL1 (per JEDEC J-STD-020D <sup>††)</sup>			
RoHS Compliant	Yes				

- † Qualification standards can be found at International Rectifier's web site http://www.irf.com/product-info/reliability
- †† Applicable version of JEDEC standard at the time of product release.

### **Revision History**

Date	Comments
3/25/2014	Corrected figure 6 - Normalized On-Resistance vs. Temperature graph on page 4.
2/19/2015	<ul> <li>Updated E<sub>AS (L=1mH)</sub> = 149mJ on page 2</li> <li>Updated note 9 "Limited by T<sub>Jmax</sub>, starting T<sub>J</sub> = 25°C, L = 1mH, R<sub>G</sub> = 50Ω, I<sub>AS</sub> = 17A, V<sub>GS</sub> =10V" on page 3</li> </ul>
05/14/2015	<ul> <li>Updated registered trademark from DirectFET<sup>™</sup> to DirectFET<sup>®</sup> on page 1,9 and 10.</li> </ul>



IR WORLD HEADQUARTERS: 101 N. Sepulveda Blvd., El Segundo, California 90245, USA

To contact International Rectifier, please visit <a href="http://www.irf.com/whoto-call/">http://www.irf.com/whoto-call/</a>

<sup>\*</sup> Industrial qualification standards except autoclave test conditions.

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